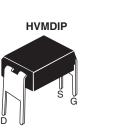
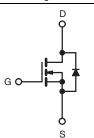


### **Power MOSFET**

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	10	100				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	0.27				
Q <sub>g</sub> (Max.) (nC)	16	16				
Q <sub>gs</sub> (nC)	4.4	4.4				
Q <sub>gd</sub> (nC)	7.7					
Configuration	Sing	Single				





N-Channel MOSFET

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION			
Package	HVMDIP		
Lead (Pb)-free	IRFD123PbF		
Lead (Fb)-liee	SiHFD123-E3		
SnPb	IRFD123		
OIII D	SiHFD123		

ABSOLUTE MAXIMUM RATINGS $(T_A$	•					
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	100	V	
Gate-Source Voltage			$V_{GS}$	± 20	] V	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>A</sub> = 25 °C		1.3	А	
Continuous Drain Current		T <sub>A</sub> = 100 °C	I <sub>D</sub>	0.94		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	10	1	
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	100	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	1.3	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	0.13	mJ	
Maximum Power Dissipation T <sub>A</sub> = 25 °C		P <sub>D</sub>	1.3	W		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	00	
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>	°C	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 22 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 2.6 A (see fig. 12).
- c.  $I_{SD} \le 9.2$  A,  $dI/dt \le 110$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFD123, SiHFD123

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	$R_{thJA}$	-	120	°C/W	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I <sub>D</sub> = 1 mA	-	0.13	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> :	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V		-	-	25	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 80 V	', V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 0.78 A^b$	-	-	0.27	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	50 V, I <sub>D</sub> = 0.78 A <sup>b</sup>	0.80	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V		-	360	-	pF
Output Capacitance	C <sub>oss</sub>	]	V <sub>DS</sub> = 25 V		150	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	34	-	
Total Gate Charge	Qg			-	-	16	nC
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V	$I_D = 9.2 \text{ A}, V_{DS} = 80 \text{ V}$ see fig. 6 and 13 <sup>b</sup>	-	-	4.4	
Gate-Drain Charge	Q <sub>gd</sub>	. See lig. 0 and 13		-	-	7.7	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 50 V, $I_{D}$ = 9.2 A $R_{g}$ = 18 $\Omega$ , $R_{D}$ = 5.2 $\Omega$ , see fig. 10 <sup>b</sup>		-	6.8	-	- ns
Rise Time	t <sub>r</sub>			-	27	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	18	-	
Fall Time	t <sub>f</sub>			-	17	-	
Internal Drain Inductance	$L_D$	6 mm (0.25") f	Between lead, 6 mm (0.25") from		4.0	-	nH
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	6.0	-	
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.3	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	10	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 1.3  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	2.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 00 1	0.0 A 41/4+ 400 A / b	-	130	260	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 9.2  \text{A}, dI/dt = 100  \text{A/} \mu \text{s}^{\text{b}}$		-	0.65	1.3	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					L <sub>D</sub> )

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

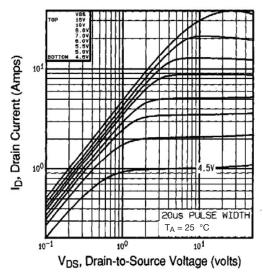


Fig. 1 - Typical Output Characteristics,  $T_A = 25$  °C

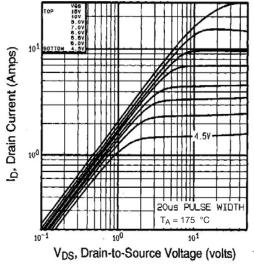


Fig. 2 - Typical Output Characteristics,  $T_A$  = 175 °C

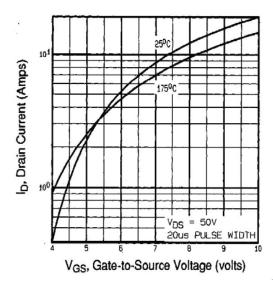


Fig. 3 - Typical Transfer Characteristics

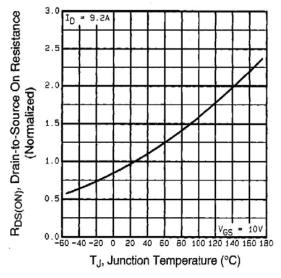


Fig. 4 - Normalized On-Resistance vs. Temperature



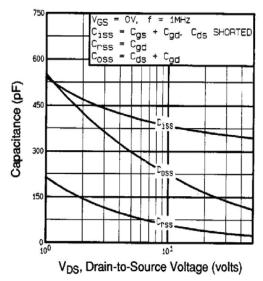


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

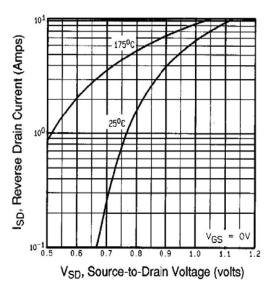


Fig. 7 - Typical Source-Drain Diode Forward Voltage

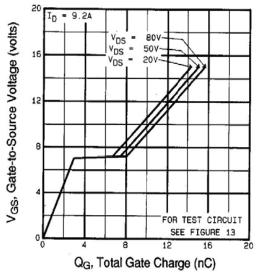


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

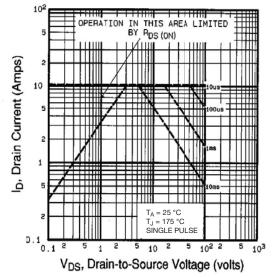


Fig. 8 - Maximum Safe Operating Area





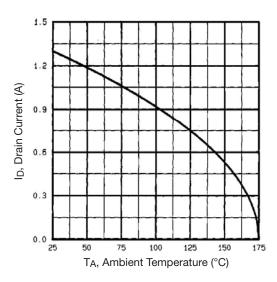


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

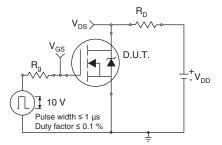


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

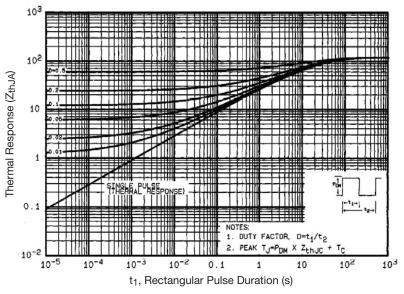


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



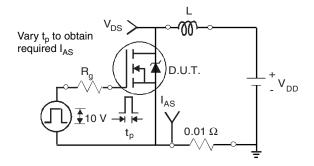


Fig. 12a - Unclamped Inductive Test Circuit

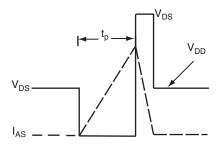


Fig. 12b - Unclamped Inductive Waveforms

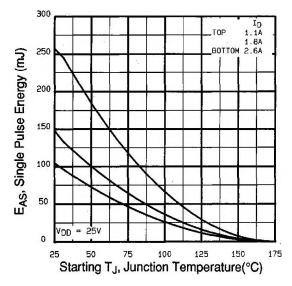


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

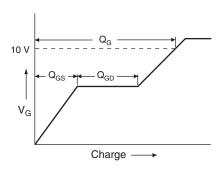


Fig. 13a - Basic Gate Charge Waveform

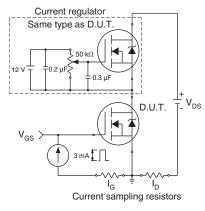
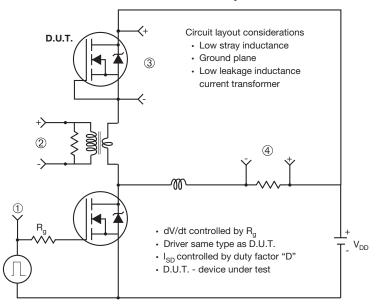


Fig. 13b - Gate Charge Test Circuit





#### Peak Diode Recovery dV/dt Test Circuit



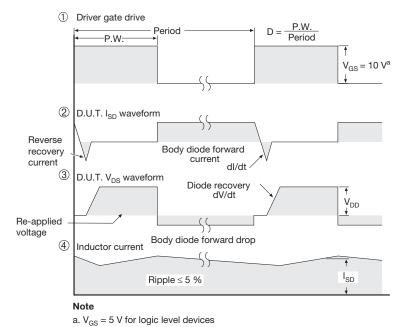


Fig. 14 - For N-Channel

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### **HVM DIP** (High voltage)





	INCHES		INCHES MILLIMETERS		IETERS
DIM.	MIN.	MAX.	MIN.	MAX.	
A	0.310	0.330	7.87	8.38	
Е	0.300	0.425	7.62	10.79	
L	0.270	0.290	6.86	7.36	

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

#### Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10



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